



Analysis of ν_{μ} CC Events

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Outline



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Motivation



Analysis of the muon charged current events is important for several reasons :

- 1) We use the muon events to determine the **neutrino energy spectrum**.
- 2) We must demonstrate that our event selection and reconstruction programs are working properly; the muon events provide a relatively **high statistics, simple topology** sample of events with which to do this.
- 3) We can locate potentially **interesting events** by studying events with muons that don't link to the primary emulsion vertex.

Event Definition



Charged Current neutrino events can be defined by the following **measured** quantities :

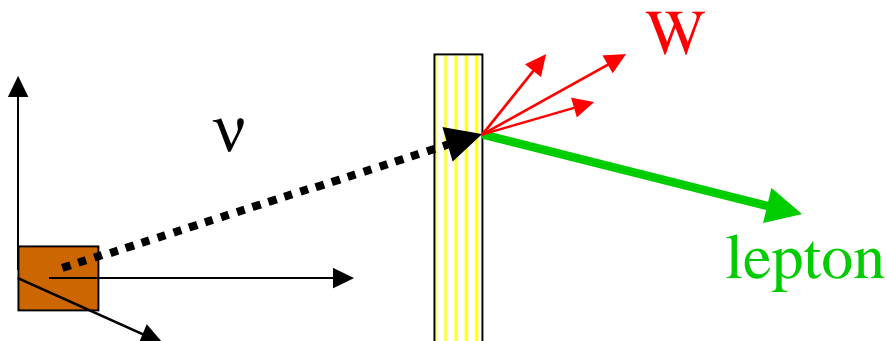
neutrino direction : \vec{p}_ν
visible energy : E_{vis}
lepton momentum : \vec{p}_1
neutrino type : from sign of \vec{p}_1

and from the following **calculated** quantities :

angle between the lepton and the jet : $\Delta\phi$

lepton transverse momentum : $p_{T \text{ lep}}$

y-distribution (from E_{vis}) : $1 - E_{\text{lep}}/E_{\text{vis}}$



Event Selection



- **Emulsion**

- Pass 1 Data : Located vertex is GIVEN
- Pass 2 Data :
 - Unique High Multiplicity Vertex is selected as the primary $\Rightarrow \geq 4$ tracks from primary
 - Select vertex with “best” number of matches to fiber lines
- For each event I verify visually that the vertex is “correct” by checking the matching of emulsion to spectrometer tracks or lines.

- **Spectrometer**

- Select events which have at least one final track with $\sum muid \geq 4$

- **Matching**

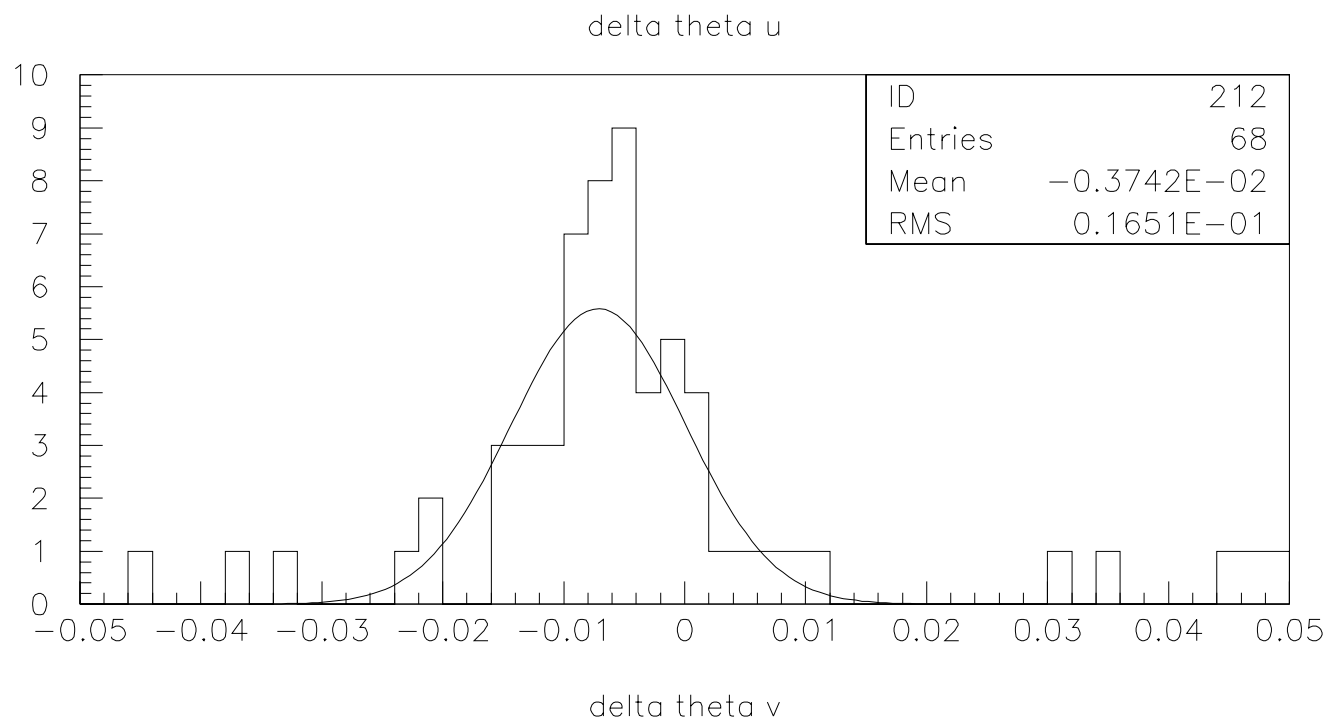
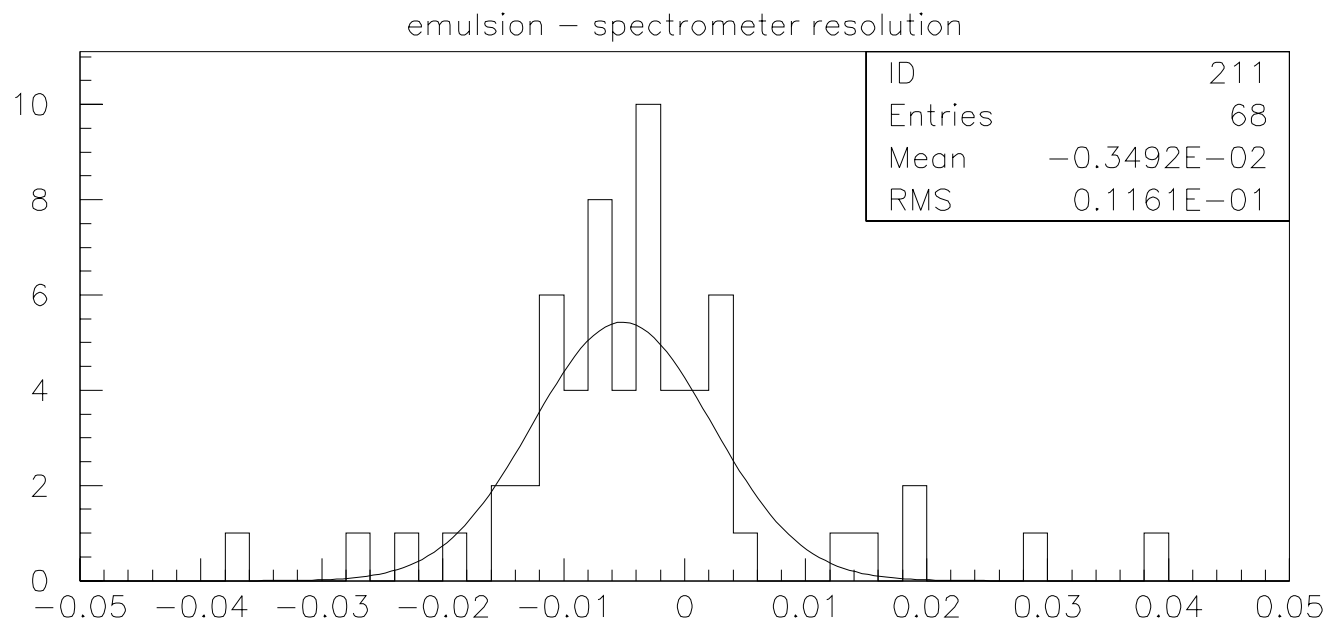
- “match” the muon(s) to the emulsion track which is closest in u and v

Measurements

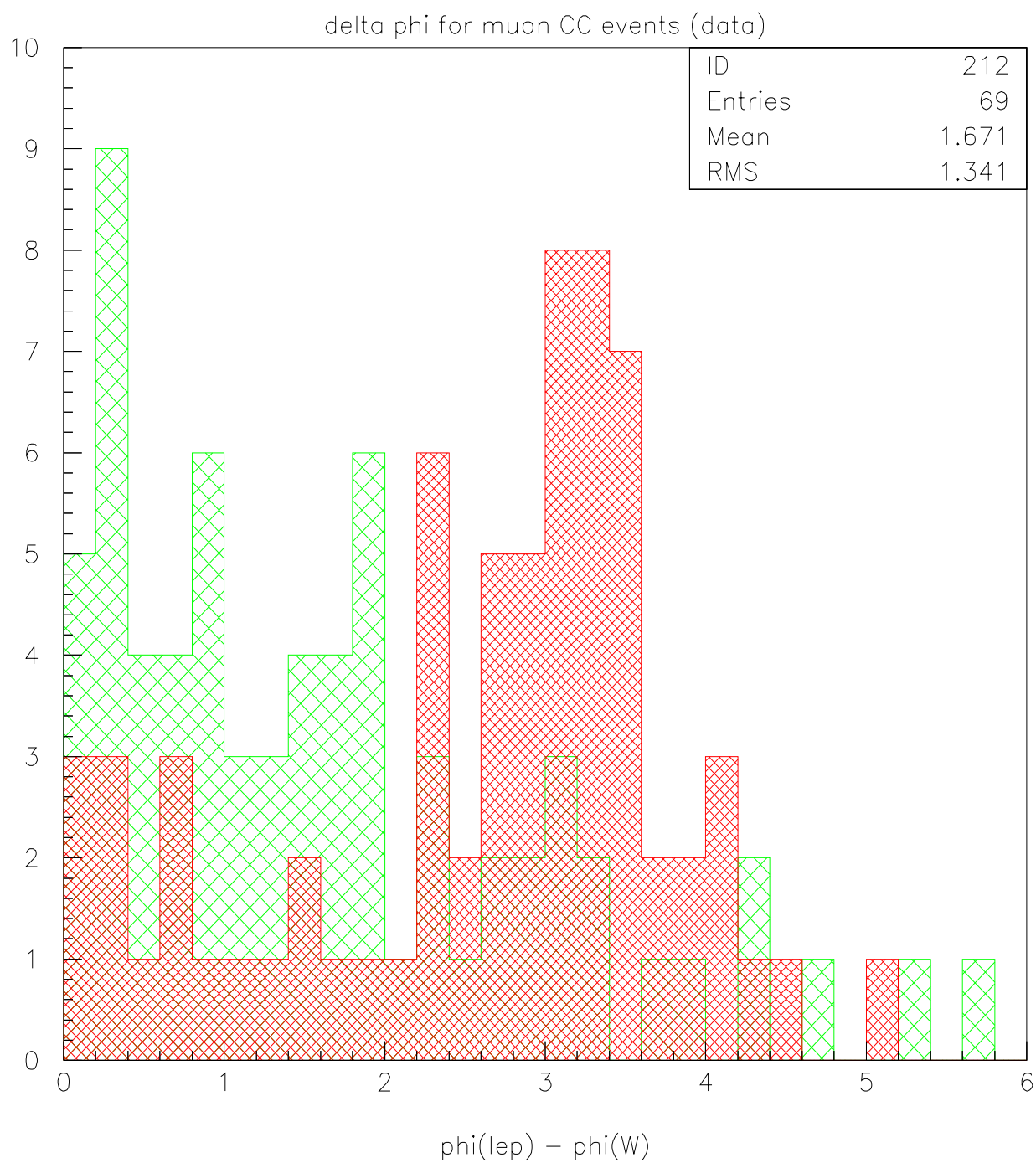


- For each event I will determine the following quantities :
 - \vec{p}_μ : magnitude and sign (spectrometer)
 - ➡ – muon track at the primary vertex (emulsion)
 - Resolution
 - ➡ – $\Delta\Phi$ in the plan transverse to \vec{p}_v
 - p_{Tlep}
 - $E_{vis} = E_{lep} + \sum E_{had} + \sum E_{em}$
 - y_{vis}

Results : $\sigma_u \sigma_v$



Results : $\Delta\phi$



Conclusion



Events :

sample will be increased by ~20% with events where the vertex has yet to be visually verified but are likely to be OK (next week);

A few events in the present pample have poor resolution and these need to be studied in more detail and either fixed or eliminated.

Calculations:

p_{Tlep} is easy and will be included;
 E_{vis} requires more effort and I will begin this asap.